

<b>Notice of References Cited</b>	Application/Control No. 09/804,311	Applicant(s)/Patent Under Reexamination SHIMADA ET AL	
	Examiner Edward Wojciechowicz	Art Unit 2815	Page 1 of 1

**U.S. PATENT DOCUMENTS**

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**FOREIGN PATENT DOCUMENTS**

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X	N	11-054716A	02-1999	Japan	Hisashi et al	257/295
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